



(19) Europäisches Patentamt
European Patent Office
Office européen des brevets



(11) Publication number : **0 456 054 B1**

(12)

EUROPEAN PATENT SPECIFICATION

(45) Date of publication of patent specification :
20.12.95 Bulletin 95/51

(51) Int. Cl.⁶ : **H01K 1/08, H01J 1/13**

(21) Application number : **91106807.0**

(22) Date of filing : **26.04.91**

(54) **Low sag tungsten filaments and their use in lamps**

(30) Priority : **09.05.90 US 521201**

(43) Date of publication of application :
13.11.91 Bulletin 91/46

(45) Publication of the grant of the patent :
20.12.95 Bulletin 95/51

(84) Designated Contracting States :
DE GB NL

(56) References cited :
EP-A- 0 196 513
GB-A- 1 053 020

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EP 0 456 054 B1

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Description**BACKGROUND OF THE INVENTION****Field of the Invention**

This invention relates to an improved, sag resistant tungsten filament and its use in lamps. More particularly, this invention relates to a tungsten filament being at least about 85% recrystallized and having a microstructure comprising a large, elongated and interlocking grain structure, a method for producing same and its use in electric lamps.

Background of the Disclosure

The use of tungsten filaments in electric lamps, such as incandescent lamps, is well known and old to those skilled in the art. The efficiency or efficacy as well as the light output and color rendering ability of an incandescent lamp is very much dependent on the temperature at which the filament operates. The filament temperature also determines the quality of the emitted light. Generally, the more efficient incandescent lamps, such as tungsten-halogen lamps, employ filaments in the form of coils or helixes and more particularly coiled-coils or double helixes in which the filaments are operated at temperatures of about 2500°C. In stage and studio lamps the filaments are operated at temperatures as high as 2900°C. Higher filament temperatures permit the use of smaller size filaments and concomitantly smaller size lamps for a given light output, which is very desirable in the market place. At the present time, the use of filaments at temperatures above about 2300°C results in substantial sag which, in turn, distorts the filament coil resulting in an increase in the radiant heat loss, thereby decreasing the luminous efficacy. Sag can also result in shorting across various portions of the coil. Tungsten ingots intended for making tungsten filaments contain a very minor amount of dopants such as potassium, aluminum and silicon. In general, tungsten ingots used to produce wire from which filaments are made consist essentially of from about 99.95 to about 99.99 wt. % of tungsten, along with minor amounts of one or more dopants and impurities.

In one prior proposal, GB-A-1053020, the filament wire, made of tungsten containing grain growth promoting additives, was alloyed with rhenium.

In fabricating the fine tungsten wire from which filaments are produced, a number of rolling, swaging, wire drawing and annealing steps must be employed. In fabricating filaments from wire, either single coil filaments or coiled-coil filaments in which there is a secondary coil, it is common practice to heat the resulting filament structure at a temperature generally ranging from about 1300-1600°C for a period of from about 1 to 10 minutes in order to slightly anneal and

stress relieve the so-formed filament. This results in a filament having an essentially unrecrystallized, fibrous microstructure such as is disclosed, for instance, by Smithells on pages 136-137 in his book "Tungsten", published in 1952 by Chapman and Hall, Ltd. (London). Such a fibrous microstructure results in a relatively weak filament having extremely little, if any, sag resistance at the 2000°C plus temperatures at which filaments are operated. Accordingly, those skilled in the art know that such filaments have to be recrystallized such as is disclosed, for example, by Smithells on pages 136-145 and in U.S. Patent Nos. 3,927,989 and 4,296,352. Both of these patents disclose that tungsten wire filaments normally recrystallize at a temperature in the general range of between about 1900-2500°C. The most ideal filament would be one formed of a single crystal of tungsten or one that was recrystallized in a manner so as to form a single crystal of tungsten. Such a filament would have the maximum possible sag resistance and tensile strength. However, at the present time no one has been able to make such a filament and there is still a great need in the art for filaments of improved high temperature sag resistance for use in more compact and efficient lamps.

The present invention seeks to provide a coiled tungsten filament having enhanced sag resistance.

SUMMARY OF THE INVENTION

According to the invention, there is provided a coiled tungsten filament having an elongated and interlocking grain micro-structure being at least about 85% recrystallized and having a Grain Shape Parameter (GSP) of at least about 10, GSP being defined as Grain Aspect Ration (GAR) divided by Grain Boundary Factor (GBF),

$$GBF = \frac{\sum \frac{\lambda}{h_2} \cos^2 \theta}{N_B}$$

wherein λ is the reciprocal of the number of boundary undulations across the diameter, h is the amplitude of an undulation with reference to a line connecting the ends of the grain boundary, both λ and h being averaged and expressed as fractions of the diameter, and θ being the angle between said line and the diameter, GAR being defined as kN_T/N_B , wherein N_T is the number of primary turns of the filament, N_B is the number of grain boundaries of the filament, and k the length of the primary turns divided by the filament diameter.

Preferably the filament has a GAR of at least 50 and more preferably at least about 100.

The filament has a grain shape parameter (GSP) having a value of at least about 10 and preferably at least about 15. the value of the grain shape parameter is equal to the value of the grain aspect ratio (GAR) divided by the value of the grain boundary factor

(GBF). The GBF and a method for obtaining same is set forth under DETAILED DESCRIPTION below, but basically it relates to the interlocking nature of the boundary of adjacent tungsten crystals or grains in a filament, with relatively straight grain boundaries transverse to the longitudinal axis of the wire being the poorest and resulting in the greatest amount of sag (as Smithells also shows on pages 136 and 137 of his book). The GAR or grain aspect ratio is the average grain or crystal length to diameter ratio. The GSP or grain shape parameter is a figure of merit which combines the properties of the other two parameters. In the present invention, large numerical values for GAR and GSP are desirable, whereas smaller values are preferred in the GBF. In general, as set forth above, the GSP will preferably have a value of at least about 10 and preferably at least about 15. The GAR will have a value of at least about 50 and preferably at least about 100 and the GBF will preferably have a value less than about 15 and preferably less than about 8. The filament of this invention will be at least about 85% recrystallized and preferably at least about 95% recrystallized and may be used at temperatures above 2300°C with little or no sag. The filaments of this invention may be uncoiled wire, single coil, double and even triple coils, as well as tungsten ribbon. The present invention also relates to lamps containing tungsten filaments having the microstructure of the present invention.

BRIEF DESCRIPTION OF THE DRAWINGS

The invention will now be described in greater detail, by way of example, with reference to the drawings, in which:-

Figures 1 and 2 schematically illustrate a portion of a filament according to the present invention illustrating interlocking grains and steps employed in obtaining the GBF.

Figure 3 is a time-temperature graph of a single anneal process used to anneal filaments and obtain the grain structure according to the invention.

Figure 4 schematically illustrates single and double ended incandescent lamps each having a filament according to the present invention.

Figure 5 schematically illustrates a combination double ended tungsten halogen lamp having a filament of the present invention, IR filter and a parabolic reflector.

DETAILED DESCRIPTION

As set forth above, the present invention relates to a tungsten filament having a microstructure which comprises a large, elongated and interlocking grain structure which is defined by a grain shape parameter (GSP) having a value of at least about 10, wherein the GSP is equal to the value of the grain aspect ratio

(GAR) divided by the value of the grain boundary factor (GBF). Those skilled in the art know that tungsten filaments are formed from fine tungsten wire having a wire diameter generally less than about 2.54mm (10 mils). A method for evaluating and obtaining these three parameters is set forth below.

In order to ascertain the nature, extent and type of grain boundaries in filaments or wires having the properties under this invention, it is first necessary to 5 thermally etch same by heating at a high temperature in a vacuum or inert atmosphere or in-situ in a lamp for a time sufficient to reveal the grain boundaries. Such thermal etching produces thermal grooving or 10 rounding of grain boundaries which makes them more visible and can generally be done at a relatively wide 15 range of temperatures of from between about 2400-2700°C for periods of time, depending upon the temperature and atmosphere, of from about 2 to 24 20 hours. By way of an illustrative, but non-limiting example, 4 hours at a temperature of 2450°C in vacuum 25 has been found satisfactory in most cases in the context of the present invention. Alternatively, a filament 30 may be thermally etched in-situ in a lamp by energizing the lamp at its rated voltage for at least about fifty (50) hours. After the filaments or wires have been etched, they are then placed in a field emission scanning electron microscope, such as a Hitachi S-800 field emission scanning electron microscope (SEM) which has a resolution capability of about 2×10^{-11} m (20 Å) and a depth of field of 100µm at 1000X magnification,

Figure 1 schematically represents such an image taken as a section of a schematically depicted coil section of a filament shown in Figure 2(a). Figure 1 35 also illustrates the step-by-step procedures taken in the grain shape analyses. The measurements are straightforward and can be made directly on the viewing screen (CRT) of an SEM or on photographs taken by the SEM. As illustrated in Figures 1(a) and 40 1(b), the first step is to find one end of a grain boundary A, then another end of the same grain boundary C, and one edge B of the wire. It is axiomatic, of course, that the diameter of the grain or tungsten 45 crystal is substantially the same as the diameter of the wire or filament. A line AB is drawn which defines the one edge of the wire and another line is drawn normal to AB as shown in Figure 1(c), D being the edge of the other side of the wire and line AD defining the 50 diameter of the wire. Line AC is then drawn in that portion of the grain boundary which crosses AC and the maximums and minimums marked with X's as shown in Figure 1(d). As the filament is continuously scanned, each subsequent grain boundary is analyzed in the same fashion. When the entire length has been 55 scanned, a mean value for GBF may be determined. The grain boundary factor, GBF, is based on the relationship:

$$GBF = \frac{\sum \frac{\lambda}{h^2} \cos^2 \theta}{N_b}$$

where N_b is the number of grain boundaries measured. The angle, θ , of a grain boundary is determined as shown in Figures 1 and 2 as the angle between AC and AD. The wave length, λ , is the reciprocal of the number of waves (boundary undulations) across the diameter of the filament wire. Height, h , or amplitude of a wave is determined as shown in Figure 2 by reference to the line AC (Figure 1) connecting the ends of the boundary. In some cases it has been found convenient to measure peak to peak amplitudes and divide by two. Both λ and h are averaged and expressed as fractions of the wire diameter.

The grain aspect ratio, GAR, is determined by means of the equation:

$$GAR = \frac{kN_T}{N_B}$$

where N_T is the number of primary turns examined and N_B is the number of grain boundaries observed. The length of a primary turn divided by the wire diameter is k and is constant for a given filament design.

When the average GBF and GAR have been determined, the grain shape parameter, GSP, is determined for a filament or a population of filaments as:

$$GSP = \frac{GAR}{GBF}$$

These analyses and calculations have also been accomplished by use of a suitable computer program with an image analyzer, such as a Tracor Northern TN8500 Image Analyzer.

The more convoluted or interlocking the grain boundary is, the stronger is the lamp filament. This interlocking feature may be described by two parameters or features. One is the amplitude h of the waviness of the grain boundary. The other is the wavelength λ . Another feature of the grain boundary which can be quantified is the angle θ it makes with respect to the plane of the cross-section of the wire. In coiled filaments the maximum stress is exerted across the cross-section normal to the longitudinal axis of the wire. Therefore, a greater angle θ results in lower stress on the boundary. Grain boundary length also increases with increasing angle θ . The GBF combines all these terms as $GBF = (\lambda/h^2) \cos^2 \theta$.

In addition to the average quality of a filament's grain boundaries, it is important to determine how many are contributing to filament creep. The parameter chosen to represent this feature is the Grain Aspect Ratio, the average grain length to diameter ratio. This is a familiar, as well as convenient parameter, since it is so frequently associated with high temperature creep performance. In the case of lamp filament wire, where the diameter of a grain is invariably the diameter of the wire, Grain Aspect Ratio is essentially the reciprocal of the number of grain boundaries mul-

tiplied by the length evaluated and divided by the wire diameter. The higher the Grain Aspect Ratio, the fewer sliding boundaries can contribute to filament creep and the stronger is the filament.

5 All of the features described above are combined to provide a figure of merit for recrystallized lamp filament microstructures called the GSP.

Tungsten filaments having the properties according to this invention have been produced by two 10 different processes. One process is a continuous heating process, whereas the other process is a two-stage, discontinuous heating process with cooling to room temperature between each heating stage. In either case the process starts with a coiled filament or filament coil having essentially 0% recrystallization. During the wire-forming and annealing processes employed to produce tungsten filament wire the tungsten wire develops a fibrous microstructure which remains essentially unchanged during the 15 subsequent forming of the filament. The fibrous microstructure results in very ductile tungsten, but at the high temperatures of 2300°C or more at which filaments are heated in lamps in order to produce light, this fibrous structure rapidly recrystallizes resulting in sagging and breaking of the filament. Accordingly, 20 those skilled in the art know that after a tungsten filament has been formed it must be heated to recrystallize the tungsten at least to some degree in order to obtain a filament with a microstructure having 25 characteristics satisfactory enough for use as a filament. In making tungsten filaments, the tungsten filament wire is first wound around a molybdenum, steel or other wire mandrel, called a primary mandrel, 30 to form a coiled structure. A single coil type of filament is used in many types of incandescent lamps. However, in the more efficient miniaturized and high 35 output lamps the tungsten filament is in the form of a double coil or a coiled-coil. In making this type of filament, the tungsten filament wire is first wound around a primary mandrel to form the first coil, with the so-formed coil structure then wound around a secondary mandrel to form the secondary coil. After 40 the filament has been completely formed and annealed to minimize elastic springback after subsequent mandrel dissolve, it is removed from the secondary mandrel and placed in an acid bath containing 45 acid such as a mixture of nitric and sulphuric acids and water which is well known to those skilled in the art and is disclosed, for example, in U.S. Patent 50 4,440,729. This is done to dissolve away the primary (and secondary) mandrel to yield the final filament.

In the continuous annealing method of this invention, a coiled-coil filament is processed with a recrystallization time-temperature schedule consisting of 55 about 30 seconds with about 2650°K maximum temperature, followed by rapid cooling to room temperature. A typical recrystallization schedule for 60W, 120V filaments is shown in Figure 3 and has been

successfully employed with this method to produce coiled-coil filaments suitable for 60W, 120V, miniature lamps having the properties of this invention. The specific time-temperature curve in Figure 3 is representative of typical recrystallization processes which achieve 85% minimum recrystallization, but does not exclude other time-temperature treatments such as shorter times with higher maximum temperatures or longer times with lower maximum temperatures.

A preferred method for heating the filament employs a tungsten mandrel inside the center of the filament which is heated by passing electrical current through it, thereby indirectly heating the filament. A tungsten mandrel is placed inside the center of the filament and attached to electrodes which are then energized to heat the mandrel with filament. The tungsten mandrel is slightly smaller than the secondary mandrel used to form the coiled-coil, typically 2.54mm (1.0 mil) smaller in diameter than the secondary mandrel. The heating is performed in a reducing atmosphere, such as forming gas consisting of 90% nitrogen and 10% hydrogen. Filament distortion, such as non-uniform secondary pitch or the spacing between adjacent secondary turns, is minimized if the molybdenum primary mandrel is present in the coiled-coil filament during the recrystallization heating treatment. A preferred process for the continuous annealing recrystallization method starts with a conventionally-processed coiled-coil, including first coiling on a molybdenum primary mandrel, annealing, second coiling and annealing, but not including acid dissolving of the primary mandrel. After recrystallizing the filament on a tungsten mandrel heated with electric current to produce the filament time-temperature curve in Figure 3, the molybdenum primary mandrel is then dissolved with the standard acid process. Significant interdiffusion between the tungsten filament wire and molybdenum primary mandrel occurs during the recrystallization time-temperature treatment shown in Figure 3, such that after dissolving the molybdenum mandrel in acid the tungsten filaments typically contain 500 to 3000 ppm total molybdenum concentration by weight. 60W, 120V, filaments typically contain 1000 to 2500 ppm molybdenum after recrystallization with a time-temperature treatment such as shown in Figure 3 and subsequently dissolving the molybdenum primary mandrel. It should be noted that one does not have to leave the primary mandrel in the filament during recrystallization.

Alternatively, the recrystallization heating schedule such as shown in Figure 3 could be performed by any other method to achieve the specified time-temperature treatment, such as placing the filament in a small tungsten boat and using a rapid-response furnace or attaching lead wires to the filament and directly heating the filament with an applied electrical current.

By way of an illustrative, but non-limiting example of the continuous anneal recrystallization method of this invention, 60W, 120V, coiled-coil filaments with 5.334 mm (2.1 mil) wire diameter, 152.4 mm (60 mil) outside diameter, 9.6 mm coil length and with the molybdenum primary mandrel present were loaded on a 78.74 mm (31.0 mil) tungsten mandrel attached to a programmable electric current source and heated in 90% nitrogen, 10% hydrogen to achieve the time-temperature schedule shown in Figure 3, followed by rapid cooling to room temperature. The filaments were then placed in an acid bath to dissolve the molybdenum primary mandrel. The processed filaments were 95% recrystallized, contained 1700 ppm molybdenum by weight and microstructural analysis of 28 filaments produced the following average results:

GSP 56
GAR 240
GBF 4.3

The amount of recrystallization was determined by a coil stretch test which measures the difference in the springback properties of the tungsten. These properties are controlled by the elastic-plastic stress-strain behavior changes (such as yield strength and strain hardening rate) and is reflected in different springback properties. The coil stretch test consists basically of pulling the coil axially to a fixed stretch length of about 8 times the original length, releasing the tension and measuring the relaxed length. The percent recrystallization can then be calculated from the relaxed length resulting after stretching and two reference relaxed lengths, one for 0% recrystallization and one for 100% recrystallization. The reference coils are stretched to the same fixed stretch length. The 0% recrystallized reference filament has been processed through standard coiling treatments (first coiling, annealing, second coiling, annealing and acid dissolving of mandrel), but has not been heated in any subsequent recrystallization treatments. The 100% recrystallized reference filament has been processed with a high temperature treatment to assure 100% recrystallization. For a fixed treatment time, the temperature is high enough to define a 100% recrystallized reference when filaments processed to successively higher temperatures produce no significant increase in the relaxed length after stretch testing. Stretch tests are performed after recrystallization and subsequent mandrel dissolving. Typically the relaxed length increases less than 0.02% per K increase in temperature for recrystallization treatments defined as 100% recrystallized. The equation to compute percent recrystallization is:

percent recrystallization = $100 (l - l_0) / (l_1 - l_0)$
where l is the relaxed length of the filament after stretching to a constant stretch length, l_0 is the relaxed length of the 0% recrystallized reference filament after stretching to the same constant stretch length and l_1 is the relaxed length of the 100% recrys-

tallized reference filament after stretching to the same constant stretch length. The correlation between the stretch test and the conventional tedious metallographic procedure employing many polished and etched sections is good. This coil stretch test method has been published by Pugh and McWhorter as "An Elastic Recovery Test for Recrystallization," Metall. Trans. vol. 20A, p. 1885-1887 (Sept. 1989).

In the two-stage heating or annealing treatment of this invention, the unrecrystallized filaments were heated in a forming gas atmosphere to a temperature broadly ranging between 1250-2050°C and preferably 1650-2050°C for about 7 minutes for the first stage. The molybdenum primary mandrel was dissolved away prior to the first stage anneal and heating was accomplished by resistive heating with lead wires attached to the filaments. This first stage annealing resulted in from about 5 to 73% recrystallization, depending on the temperature, with the higher temperatures being preferred.

After the first anneal, the partially recrystallized filaments were briefly cooled to room temperature and then rapidly heated again using a conventional pulsed resistive heating or flashing technique pulsing temperatures starting at 2200°K up to 3200°K over a period of about twenty seconds. Double coiled filaments made with this method for 45 watt (120V) tungsten halogen lamps exhibited essentially about 100% recrystallization and virtually no sag when the first anneal was accomplished in the 1650-2050°C range. These filaments were coiled-coil filaments about 12 mm long from 0.06 mm diameter wire doped with potassium (GE 218 grade). Filaments have been made in this manner having a GSP of 86, a GBF of 4.4 and a GAR of 289. Filaments having similar properties according to the invention have also been made by heating in tungsten boats in a conventional furnace in a forming gas atmosphere.

In contrast to the filaments of this invention, filaments of similar construction taken from competitive tungsten halogen lamps made by another manufacturer exhibited a GAR of from about 12 to 22 and a GSP of from about 0.5 to 4.3.

Most of the filaments made according to this invention were made from a standard grade of tungsten filament wire made and available from GE Lighting located at Tungsten Road in Cleveland, Ohio, and designated as their GE Type 218 wire. This wire has a purity of 99.95+ % W and is doped with potassium ranging from 65-80 ppm. Filaments having characteristics according to this invention have also been made from tungsten filament wire obtained from competitive wire manufacturers, both in the U.S. and Japan.

Figure 4 schematically illustrates various types of lamps containing filaments according to the present invention. Thus, referring to Figure 4(a), lamp 10 has a tubular envelope made of a suitable light transmissive vitreous envelope 12 formed from a high temper-

ature aluminosilicate glass which may be of the type disclosed and claimed in U.S. Patent 4,737,685 the disclosures of which are incorporated herein by reference. A coiled-coil tungsten filament 13 having properties according to the present invention is connected to and supported within said vitreous envelope by in-lead wires 14 and 16 made of molybdenum and which extend through a customary pinch seal 18. If desired, molybdenum inleads 14 and 16 can be connected by means of welding, brazing or other suitable means to less costly metals of a greater or the same diameter to provide electrical connection for the filament and support for the lamp. Envelope 12 may also contain a fill comprising a mixture of nitrogen, hydrogen, noble gas, phosphorus, and a hydrogen such as chlorine and bromine.

Figure 4(b) illustrates another type of lamp useful in the practice of this invention wherein molybdenum foil is used to effect a hermetic seal in the pinch seal area, as is the practice with such lamps having quartz envelopes. Thus, lamp 20 comprises quartz envelope 22 containing two pinch-sealed inlead constructions comprising outer terminal leads 32 and 32' and inner terminal leads 26 and 26' connected to opposite ends of intermediate molybdenum sealing foils 28 and 28', respectively. A compact coiled-coil tungsten filament 24 made according to the invention is attached at one end to inner lead 26 and at the other end to inner lead 26'. The leads are connected to the molybdenum sealing foils by suitable means, such as welding. Leads 26 and 26' are made of molybdenum. Envelope 22 also contains a fill comprising a mixture of noble gas, hydrogen, a getter such as phosphorus, and a halogen such as chlorine, bromine and optionally, nitrogen.

Figure 4(c) illustrates a double-ended miniature lamp 50 comprising a light transmissive, fused silica (quartz) envelope portion 40 containing a coiled-coil tungsten filament 60 according to the present invention welded at each end to filament spuds 62 and 62' wherein both tubular end portions 54 and 54' have been shrink sealed over foil members 64 and 64' to form a hermetic seal and then cut to reduce their length to that desired. Outer leads 56 and 56' extend past the end of tube portions 54 and 54' which are cut to the desired length after assembly of the lamp. Shrink seals are preferred because deformation and misalignment of the tube portions of the lamp envelope are minimal as compared with that which can occur with pinch sealing. Shrink seals are known to those skilled in the art and examples of how to obtain same are found, for example, in U.S. Patents 4,389,201 and 4,810,932. Lamps of this construction are commercially available and are disclosed, for example, in EP-A-0397422.

Lamp 50 is shown assembled into a parabolic reflector 61 illustrated in Figure 5. Thus, turning to Figure 5, combination 100 contains lamp 50 mounted

into the bottom portion of parabolic glass reflector 61 by means of conductive mounting legs 65 and 67 which project through seals (not shown) at the bottom portion 72 of glass reflector 61. Lamp base 80 is crimped onto the bottom portion of the glass reflector by means not shown at neck portion 82. Screw base 84 is a standard screw base for screwing the completed assembly 60 into a suitable socket. Glass or plastic lens or cover 86 is attached or hermetically sealed by adhesive or other suitable means to the other end of reflector 61 to complete the lamp assembly. Lamp 50 is also shown having coating 90 on the exterior surface of the lamp envelope for selectively reflecting infrared energy emitted by the filament back to the filament wherein at least a portion of the infrared radiation is converted to visible light.

The coating 50 is preferably made up of alternating layers of a low refractory index material such as silica and a high refractory index material such as tantalum, titania, niobia and the like for selectively reflecting and transmitting different portions of the electromagnetic spectrum emitted by the filament. In a preferred embodiment of the invention the filter will reflect infrared radiation back to the filament and transmit the visible portion of the spectrum. Such filters and their use as coatings for lamps may be found, for example, in U.S. Patents 4,229,066 and 4,587,923.

Claims

1. A coiled tungsten filament having an elongated and interlocking grain micro-structure being at least about 85% recrystallized and having a Grain Shape Parameter (GSP) of at least about 10, GSP being defined as Grain Aspect Ratio (GAR) divided by Grain Boundary Factor (GBF),

$$GBF = \frac{\sum \lambda \cos \theta}{h_2} / N_B$$

wherein λ is the reciprocal of the number of boundary undulations across the diameter, h is the amplitude of an undulation with reference to a line connecting the ends of the grain boundary, both λ and h being averaged and expressed as fractions of the diameter, and θ being the angle between said line and the diameter, GAR being defined as kN_T/N_B , wherein N_T is the number of primary turns of the filament, N_B is the number of grain boundaries of the filament, and k the length of the primary turns divided by the filament diameter.

2. The coiled tungsten filament of claim 1, having a GAR of at least 50.
3. The filament of claim 1, wherein said GAR is at

least about 100.

4. The filament of claim 3 being at least about 95% recrystallized.

5. The filament of claim 4 wherein said GAR is at least about 200.

6. The filament of claim 5 containing from about 10 500-3000 ppm molybdenum, preferably from 1000-2500 ppm molybdenum.

7. The filament of any one of claims 2 to 6 having a GBF of less than about 15.

8. The filament of claim 7 having a GSP of at least about 15.

9. The filament of claim 8 having a GBF less than about 8.

10. An incandescent electric lamp (10, 20) comprising a hermetically sealed, light transmissive envelope (12, 22), enclosing within the filament (13, 24) of any one of claims 1 to 9.

11. A tungsten halogen lamp (50) comprising a hermetically sealed, vitreous, light transmissive envelope (40) enclosing within one or more metal halides and the filament (60) of any one of claims 1 to 9.

12. The lamp (50) of claim 10 or 11, further containing a thin film optical interference coating (90) on the outer surface thereof for selectively reflecting and transmitting various portions of the light spectrum.

13. The lamp (50) of claim 12, wherein said coating (90) reflects infrared radiation back to the filament but transmits visible light radiation.

14. A tungsten-halogen lamp (100) mounted within a parabolic shaped reflector (61) with the optical center of said lamp (100) being proximate the optical center of said reflector (61), said lamp (100) having a hermetically sealed, light transmissive, vitreous envelope which contains within one or more metal halides and a tungsten filament (60) according to any one of claims 1 to 9.

Patentansprüche

55 1. Wolfram-Leuchtdrahtwendel mit einem langgestreckten und ineinandergreifenden Korngefüge, das mindestens etwa 85% rekristallisiert ist und einen Korngestalt-Parameter (GSP) von minde-

stens etwa 10 hat, wobei der GSP als Kornlängen-Verhältnis (GAR), dividiert durch den Korngrenzen-Faktor (GBF)

$$GBF = \frac{\sum \frac{\lambda}{h_2} \cos^2 \theta}{N_B}$$

definiert ist, worin λ der Kehrwert der Anzahl der Grenzwellen über den Durchmesser, h die Amplitude einer Welle mit Bezug auf eine Linie ist, die die Enden der Korngrenze verbindet, sowohl λ als auch h gemittelt und als Bruchteile des Durchmessers ausgedrückt sind und θ der Winkel zwischen der genannten Linie und dem Durchmesser ist, GAR als kN_T/N_B definiert ist, worin N_T die Anzahl primärer Windungen der Wendel ist, N_B die Anzahl der Korngrenzen des Leuchtdrahtes ist und k die Länge der primären Windungen, dividiert durch den Leuchtdrahtdurchmesser ist.

2. Wolfram-Leuchtdrahtwendel nach Anspruch 1 mit einem GAR von mindestens 50.
3. Leuchtdraht nach Anspruch 1, worin das GAR mindestens etwa 100 beträgt.
4. Leuchtdraht nach Anspruch 3, der mindestens etwa 95% rekristallisiert ist.
5. Leuchtdraht nach Anspruch 4, worin das GAR mindestens etwa 200 beträgt.
6. Leuchtdraht nach Anspruch 5, enthaltend von etwa 500-3.000 ppm Molybdän, vorzugsweise von 1.000-2.500 ppm Molybdän.
7. Leuchtdraht nach einem der Ansprüche 2 bis 6 mit einem GBF von weniger als etwa 15.
8. Leuchtdraht nach Anspruch 7 mit einem GSP von mindestens etwa 15.
9. Leuchtdraht nach Anspruch 8 mit einem GBF von weniger als etwa 8.
10. Elektrische Glühlampe (10,20), umfassend einen hermetisch abgedichteten, lichtdurchlässigen Kolben (12,22), der den Leuchtdraht (13,24) nach einem der Ansprüche 1 bis 9 einschließt.
11. Wolfram-Halogen-Lampe (50), umfassend einen hermetisch abgedichteten, lichtdurchlässigen Glaskolben (40), der ein oder mehrere Metallhalogenide und den Leuchtdraht (60) nach einem der Ansprüche 1 bis 9 einschließt.
12. Lampe (50) nach Anspruch 10 oder 11, weiter enthaltend einen optischen Dünnfilm-Interfe-

renzüberzug (90) auf der äußeren Oberfläche, um verschiedene Teile des Lichtspektrums selektiv zu reflektieren und durchzulassen.

- 5 13. Lampe (50) nach Anspruch 12, worin der Überzug (90) IR-Strahlung zurück zum Leuchtdraht reflektiert, sichtbare Lichtstrahlung aber durchlässt.
- 10 14. Wolfram-Halogen-Lampe (100), die innerhalb eines parabolförmigen Reflektors (61) montiert ist, wobei das optische Zentrum der Lampe (100) nahe dem optischen Zentrum des Reflektors (61) liegt, die Lampe (100) einen hermetisch abgedichteten, lichtdurchlässigen Glaskolben aufweist, der ein oder mehrere Metallhalogenide und einen Wolfram-Leuchtdraht (60) gemäß einem der Ansprüche 1 bis 9 enthält.

Revendications

1. Filament de tungstène hélicoïdal comportant une microstructure, à grains allongés et imbriqués, recristallisée à au moins environ 85% et présentant un Paramètre de Forme de Grain (GSP) d'au moins 10, GSP étant défini comme étant le Rapport d'Allongement de Grain (GAR) divisé par le Facteur de Joint Intergranulaire (GBF),

$$GBF = \frac{\sum \frac{\lambda}{h_2} \cos^2 \theta}{N_B}$$

où λ est l'inverse du nombre d'ondulations des joints transversalement au diamètre, h est l'amplitude d'une ondulation par rapport à une ligne reliant les extrémités du joint intergranulaire, λ et h étant mis en moyenne et exprimés comme des fractions du diamètre, et θ étant l'angle entre la dite ligne et le diamètre, GAR étant défini comme étant kN_T/N_B , sachant que N_T est le nombre de spires primaires du filament, N_B est le nombre de joints intergranulaires du filament, et k est la longueur des spires primaires divisée par le diamètre du filament.

- 35 2. Filament hélicoïdal en tungstène, présentant un GAR d'au moins 50.
- 40 3. Filament selon la revendication 1, dans lequel le dit GAR est d'au moins environ 100.
- 45 4. Filament selon la revendication 3, recristallisé à au moins environ 95%.
- 50 5. Filament selon la revendication 4, dans lequel le dit GAR est d'au moins environ 200.

6. Filament selon la revendication 5, contenant d'environ 500 à environ 3000ppm de molybdène, de préférence de 1000 à 2500 ppm de molybdène. 5

7. Filament selon l'une quelconque des revendications 2 à 6, présentant un GBF inférieur à environ 15.

8. Filament selon la revendication 7, présentant un GSP d'au moins environ 15 . 10

9. Filament selon la revendication 8, présentant un GBF inférieur à environ 8. 15

10. Lampe électrique à incandescence (10, 20) comprenant une enveloppe (12, 22) hermétiquement fermée et transmettant la lumière, dans laquelle est enfermée le filament (13, 24) selon l'une quelconque des revendications 1 à 9. 20

11. Lampe (50) à halogène et à filament de tungstène, comprenant une enveloppe vitreuse (40) fermée hermétiquement et transmettant la lumière, dans laquelle sont enfermés un ou plusieurs halogénures métalliques et le filament (60) selon l'une quelconque des revendications 1 à 9. 25

12. Lampe (50) selon la revendication 10 ou 11, contenant, en outre, un revêtement interférentiel optique (90) à film mince sur sa surface extérieure pour réfléchir et transmettre de façon sélective diverses parties du spectre de la lumière. 30

13. Lampe (50) selon la revendication 12, dans laquelle ledit revêtement (90) réfléchit les radiations infrarouges vers le filament mais transmet les radiations de la lumière visible. 35

14. Lampe (100) à halogène et à filament de tungstène, montée à l'intérieur d'un réflecteur (61) de forme parabolique, le centre optique de ladite lampe (100) se trouvant à proximité du centre optique dudit réflecteur (61), ladite lampe (100) comportant une enveloppe vitreuse, hermétiquement fermée et transmettant la lumière, laquelle enveloppe contient intérieurement un ou plusieurs halogénures métalliques et un filament (60) en tungstène selon l'une quelconque de revendications 1 à 9. 40

45

50

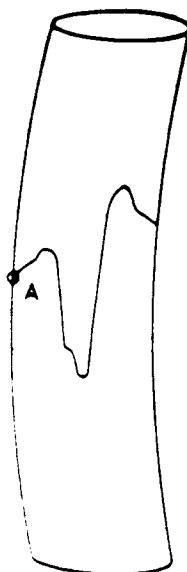


Fig. 1(a)

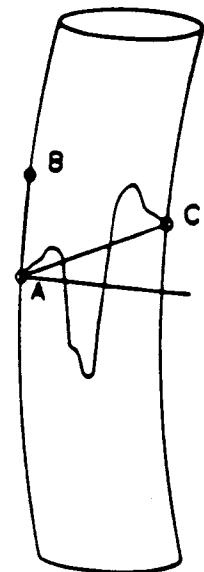


Fig. 1(b)

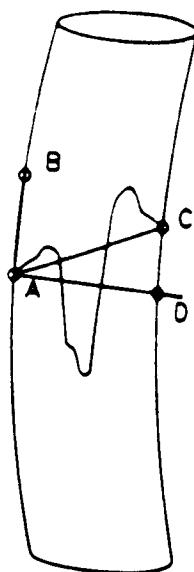


Fig. 1(c)

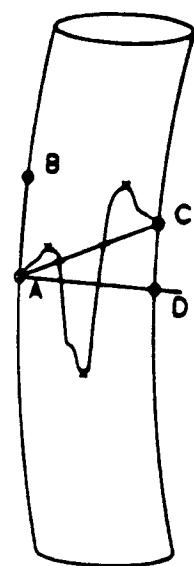


Fig. 1(d)

Fig. 2(a)

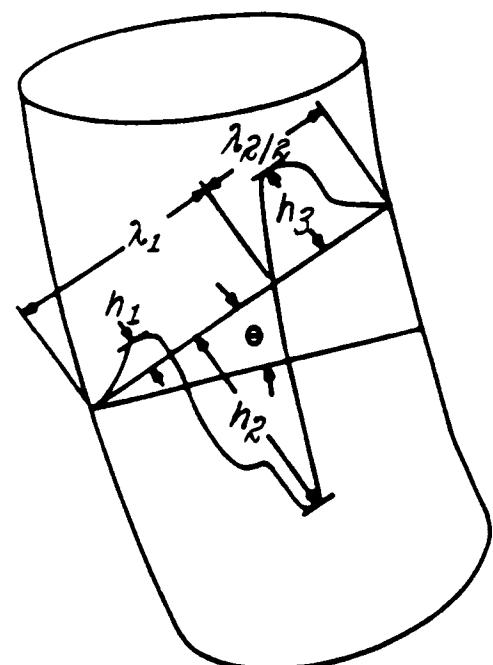
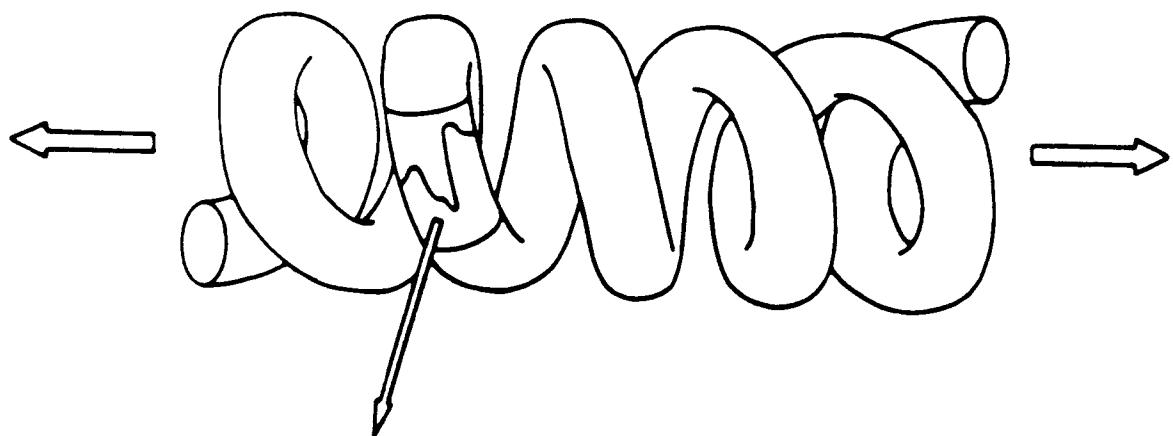


Fig. 2(b)

Fig. 3 RECRYSTALLIZATION SCHEDULE

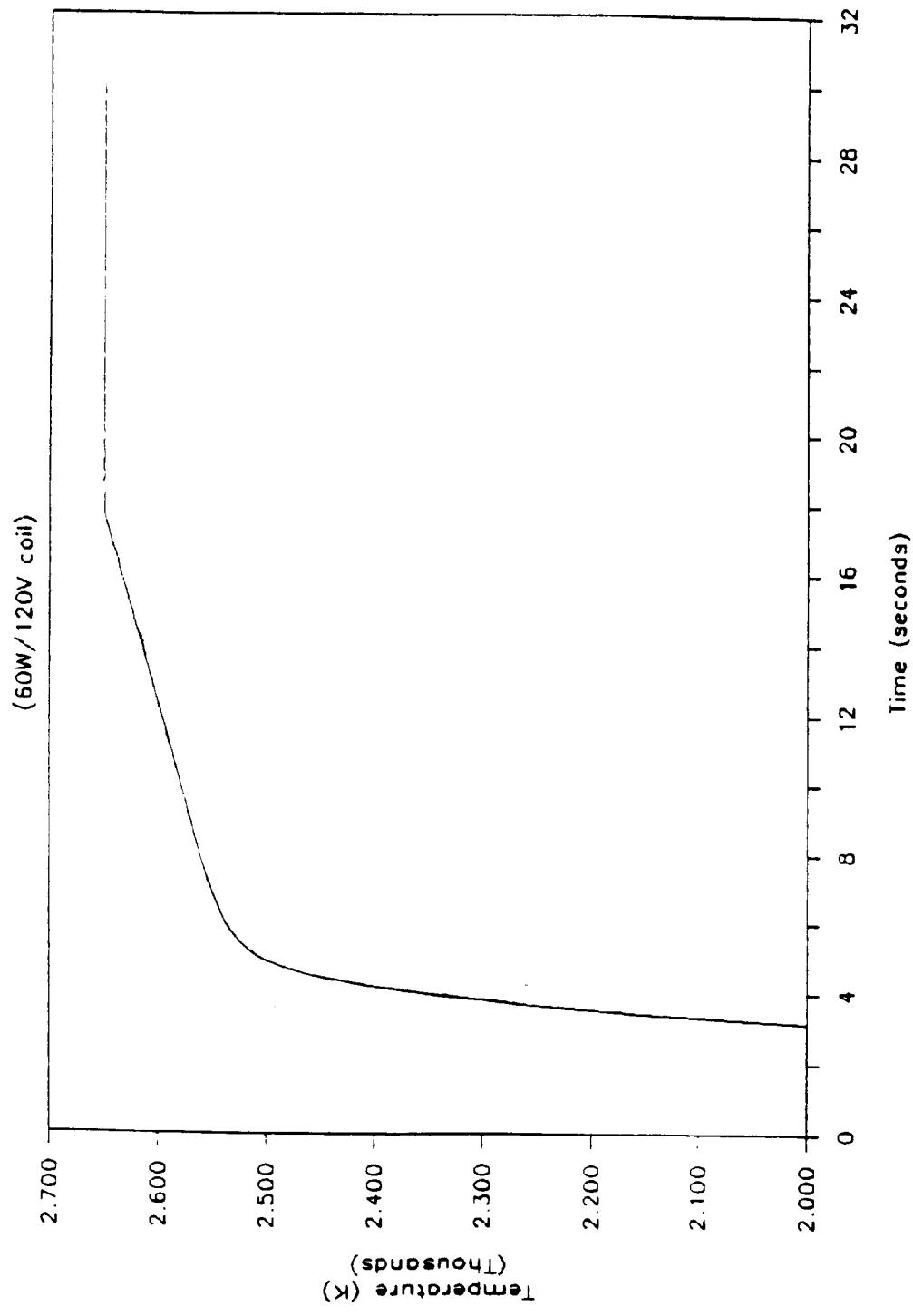
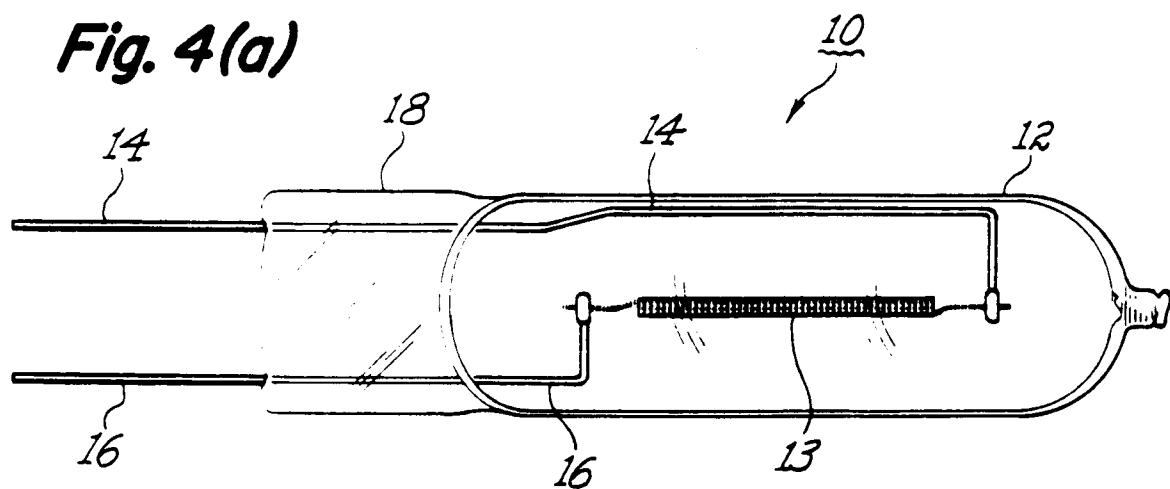
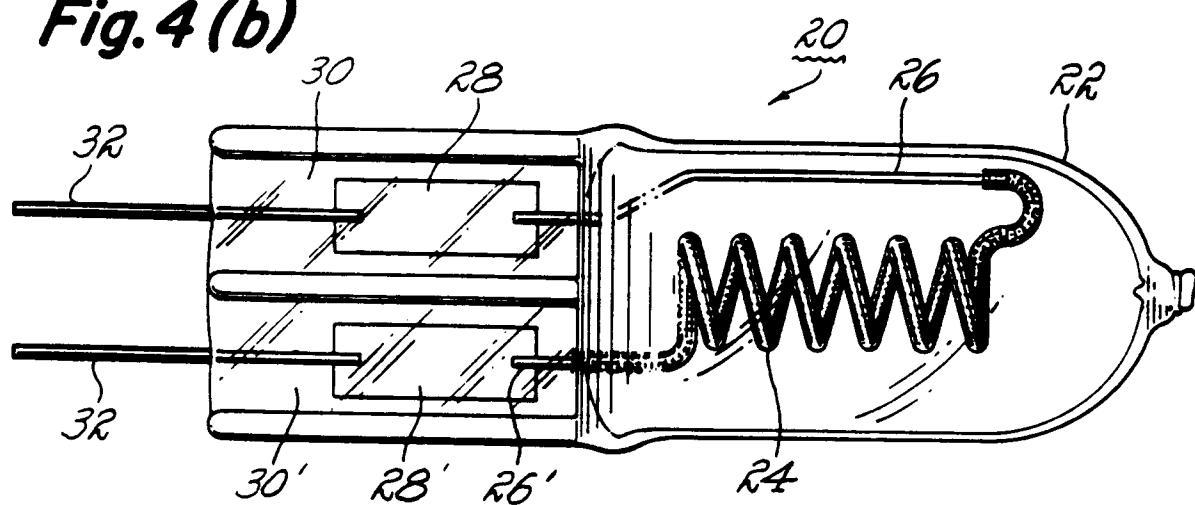
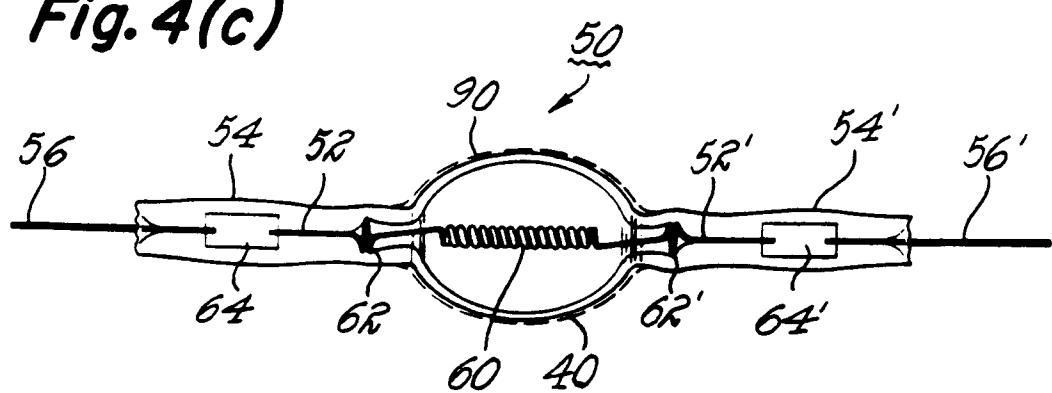


Fig. 4(a)*Fig. 4(b)**Fig. 4(c)*

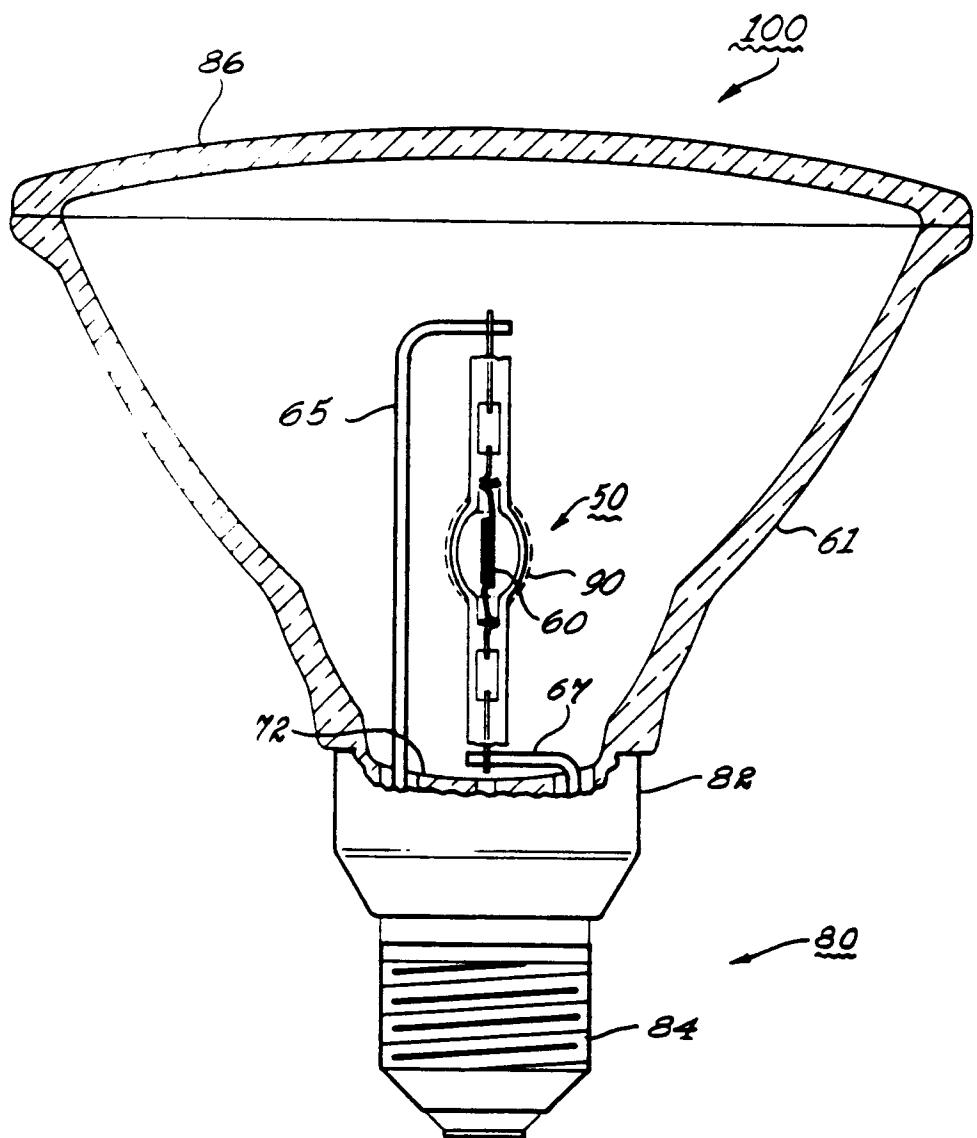


Fig. 5